

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10574950	OISHI ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	LUAT PHUNG	2416

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
370	463, 431	10/08/2008	T.N.
379	399.01	10/08/2008	T.N.
340	600, 540, 500, 561, 541	10/08/2008	T.N.
Updated	above	4/27/2009	LP
370	208, 278, 282	4/27/2009	LP
379	399.01	4/27/2009	LP
455	13.4, 522	4/27/2009	LP
Updated	above	8/7/2009	LP

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST text search (USPGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TDB)	10/8/2008	T.N.
EAS inventor search, PALM inventor searchT	10/8/2008	T.N.
Web search	4/26/2009	LP
EAST search	4/26/2009	LP
Consulted with SPE Ricky Ngo	4/23/2009	LP
Updated EAST search	8/7/2009	LP

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
370	ALL	8/7/2009	LP